

Preliminary Design Considerations for a Faraday Cup for a 5 MeV RF Photo Gun

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- Introduction: SINBAD / ARES @ DESY
- Faraday Cup Design: general Considerations
- Geant4 Simulation Results

Accelerator R&D Facility „SINBAD“



● Short Innovative Bunches and Accelerators at DESY

- ▶ currently under construction
 - re-use of former DORIS tunnel
- ▶ multiple experiments on acceleration of ultra-short electron bunches and advanced acceleration schemes
- ▶ will initially host 2 experiments:

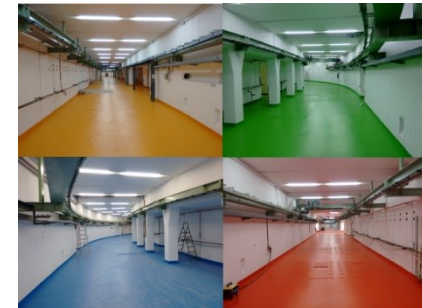
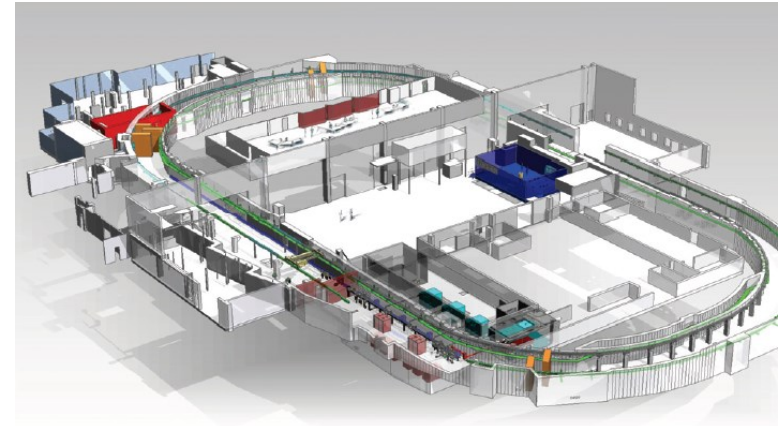
● AXSIS

- ▶ Attosecond X-ray Science: Imaging and Spectroscopy
 - ERC-synergy grant funded project
- ▶ THz acceleration in dielectric loaded waveguides
 - develop compact ~ 15 MeV accelerator
- ▶ X-ray generation via Inverse Compton Scattering (ICS)

● ARES

▶ Accelerator Research Experiment at Sinbad

- 1st step: build 100MeV electron linac for ultra-short bunches
- 2nd step: optimize performance, compare various compression techniques
- 3rd step: use of beam (ACHIP, THz experiments, Trans-National Access...)

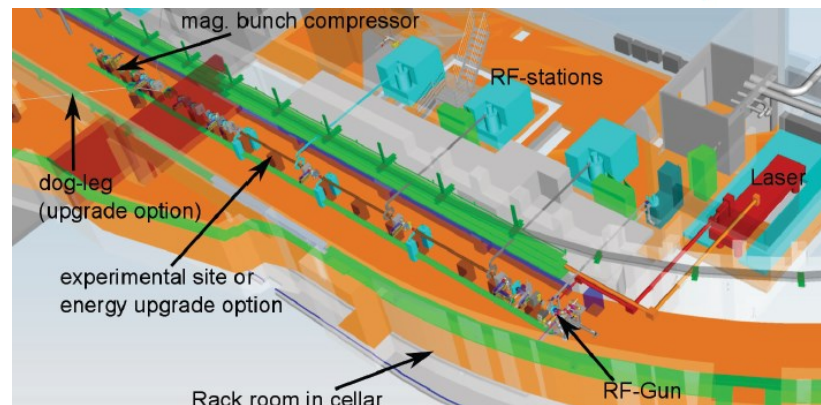


U. Dorda et al., Proc. IPAC 2017,
Copenhagen (Denmark),
MOPVA012

ARES Linac

linac parameters

- normal conducting linac
 - $E \sim 100 \text{ MeV}$, $\Delta E/E \sim 0.2\%$
 - $Q_b = 0.5 - 30 \text{ pCb}$, (sub-) fsec duration
- 2 about 4.5 m long S-band structures (upgrade: 3)
- magnetic bunch compression / velocity bunching
- upgrade option for 2nd experimental site



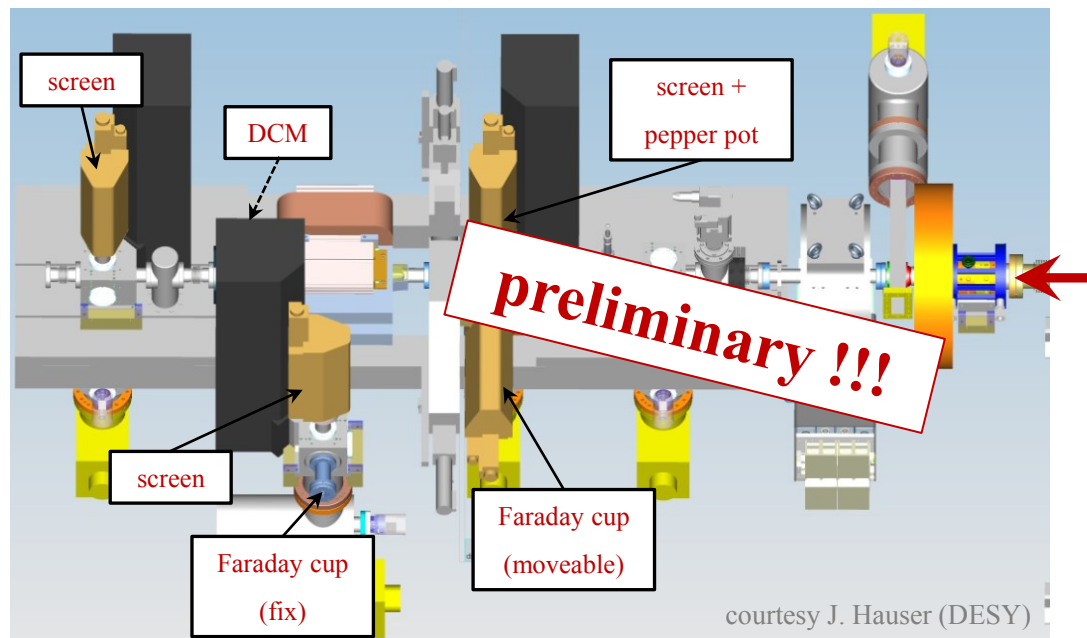
U. Dorda et al., Proc. IPAC 2017, Copenhagen (Denmark), MOPVA012

gun

- modified version of REGAE gun
 - S-band RF photo gun (5 MeV)
- followed by $\sim 2.5 \text{ m}$ long beam line
 - beam diagnostics section
- operation shall start end of 2017

moveable Faraday Cup (FC)

- compact design ($< 30 \text{ mm}$)
- particle free vacuum condition
- accuracy better than 1%



courtesy J. Hauser (DESY)

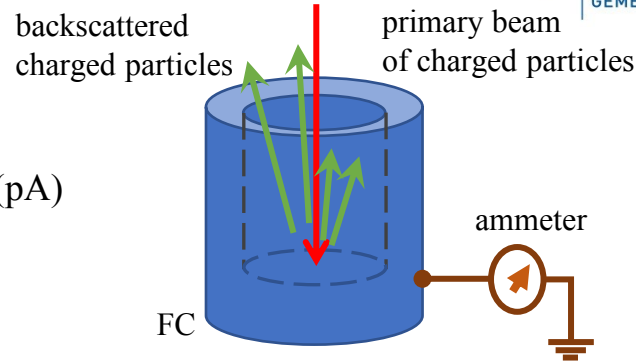
Faraday Cup

FC operational principle

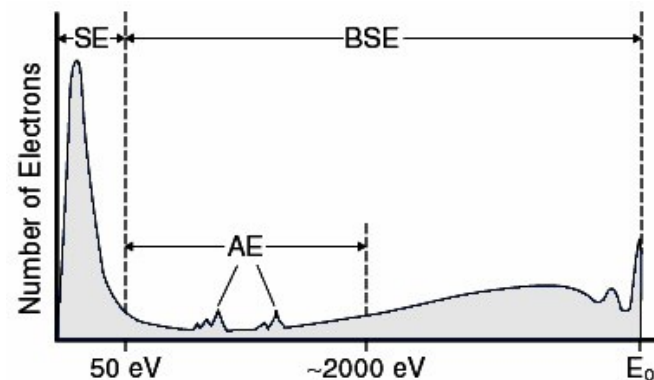
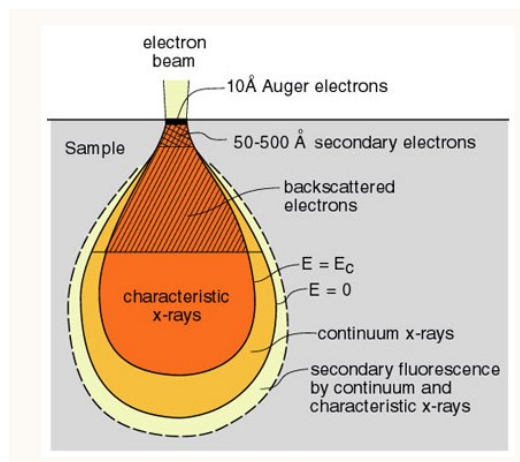
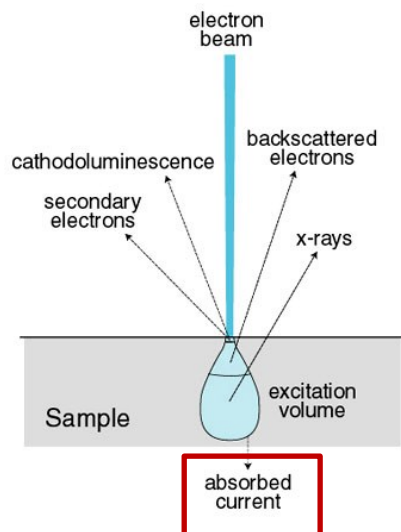
- › beam stopper, isolated from beam pipe ground potential
- › connected to current meter → sensitive to low currents (pA)

signal leakage

- › goal: minimize number of escaping electrons
 - (i) choice of material & geometry, (ii) external repelling mechanisms
- › consider experience of electron microscopy
 - use of “leakage signals“ for material analysis



- backscattered electrons (BSE)
 - elastic scattering
- secondary electrons (SE)
- Auger electrons (AE)
 - inelastic scattering
- X-rays (Bremsstrahlung)
 - particle shower



<http://nau.edu/cefns/labs/electron-microprobe/glg-510-class-notes/signals/>

Secondary- / Auger Electrons

● secondary electrons

- › takes place between incident electrons and outer (weak bound) electrons of the atom
- › outer electrons can be ejected from atom with energies lower than 50 eV
- › if SEs are produced near the surface with energy higher than surface energy ($\sim 6\text{eV}$) \rightarrow escape to vacuum



typically to neglect for MeV beams

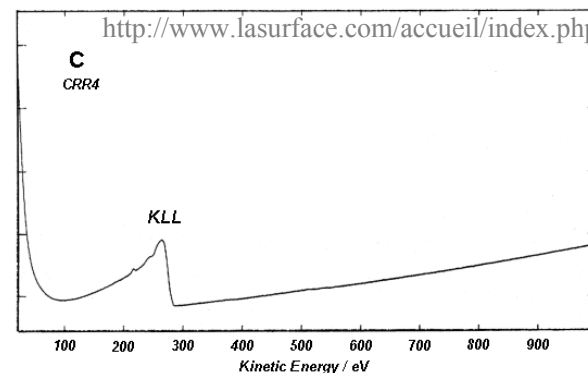
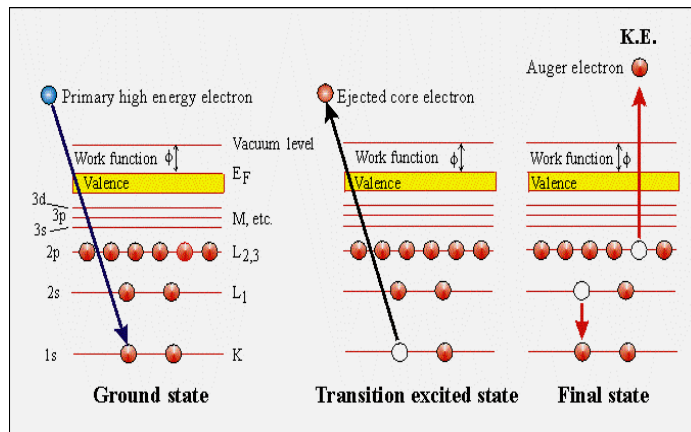
● Auger electrons

- › occurrence of electron vacancy in core level (K, L)
- › vacancy filled by secondary electron from upper energy level
- › energy of emitted electron can serve for

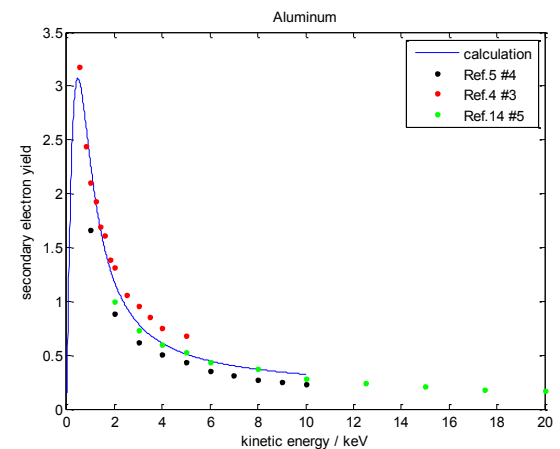
(i) emission of X-ray ($Z > 30$)

(ii) ejection of Auger electron

(non-radiative process)



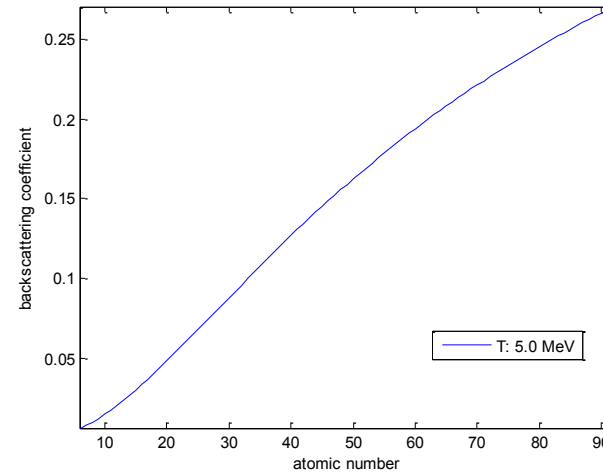
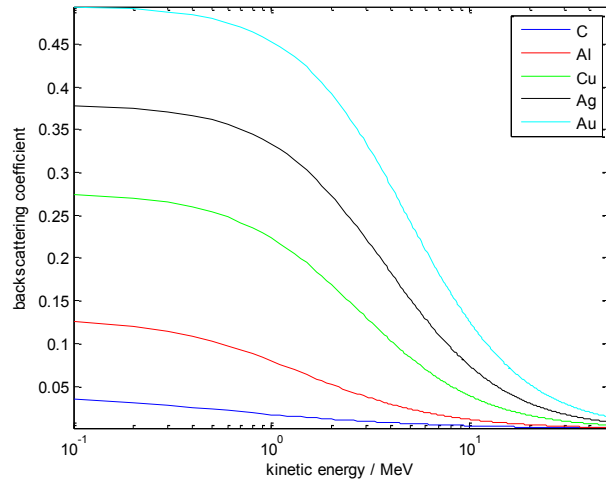
to neglect



Backscattering and Bremsstrahlung

backscattering

- parametrization for few MeV energies: T. Tabata, R. Ito and S. Okabe, Nucl. Instruments and Methods **94** (1971) 509

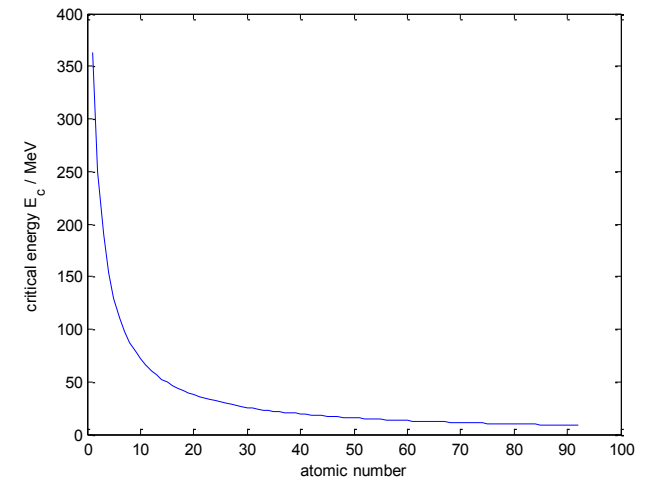


	Z	η
C	6	0.0063
Al	13	0.0234
Cu	29	0.0838
Ag	47	0.1522
Au	79	0.2431

Bremsstrahlung

- above 2×0.511 MeV: pair production
 - reduce Bremsstrahlung generation
- characterized by critical energy E_c
 - Bremsstrahlung losses = collisional losses (i.e. ionization)

reduce signal losses → use of low Z materials



Material Choice

periodic table

- suitable low-Z material → reduce signal losses

1 H																	2 He
3 Li	4 Be											5 B	6 C	7 N	8 O	9 F	10 Ne
11 Na	12 Mg											13 Al	14 Si	15 P	16 S	17 Cl	18 Ar
19 K	20 Ca	21 Sc	22 Ti	23 V	24 Cr	25 Mn	26 Fe	27 Co	28 Ni	29 Cu	30 Zn	31 Ga	32 Ge	33 As	34 Se	35 Br	36 Kr

→ Carbon

occurrence of carbon

graphite

→ DIAMOND, based on SLS design

A. Morgan, Proc. DIPAC 2005, Lyon (France), POM011

diamond

→ semiconductor, band gap ~ 5.5 eV → doping with boron ???

glassy carbon (trading name: SIGRADUR)

→ test of vacuum compatibility:

⚡ **outgasing**
(acts as sponge...)



particle free vacuum



time

final choice



Aluminum

Glassy Carbon SIGRADUR®

is an advanced material of pure carbon with exceeding material properties. ...more (English Version)

Glaskohlenstoff SIGRADUR®

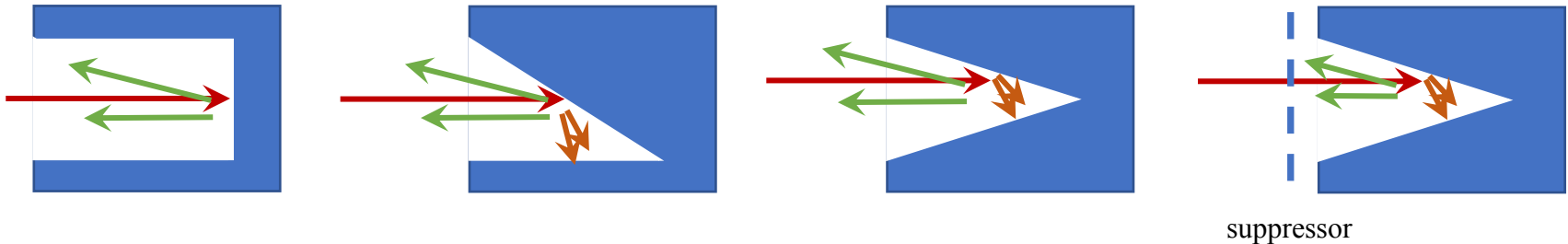
ist ein Hochleistungswerkstoff aus reinem Kohlenstoff mit außergewöhnlichen Materialeigenschaften. ...mehr (Deutsche Version)



<http://www.htw-germany.com/index.php5?lang=en&nav0=0>

Geometry

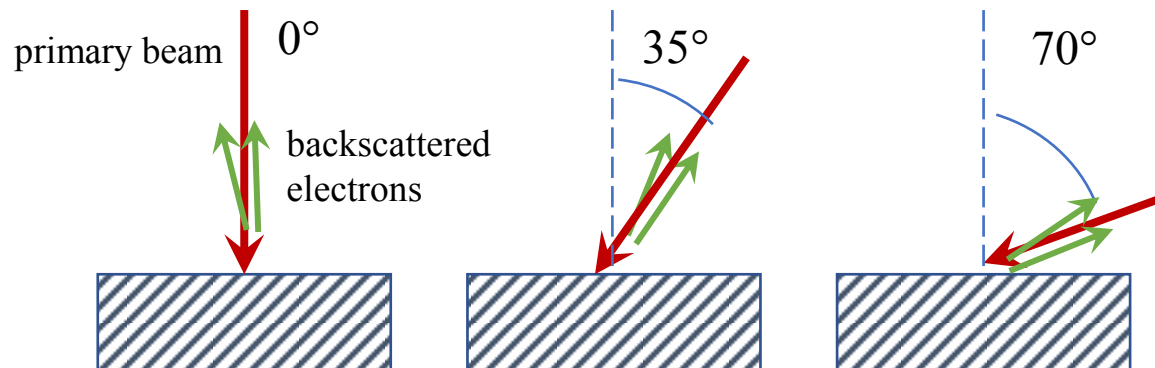
- investigation of various geometries → suppression of backscattering



- task: find geometry which produces smallest quantity of backscattered particles

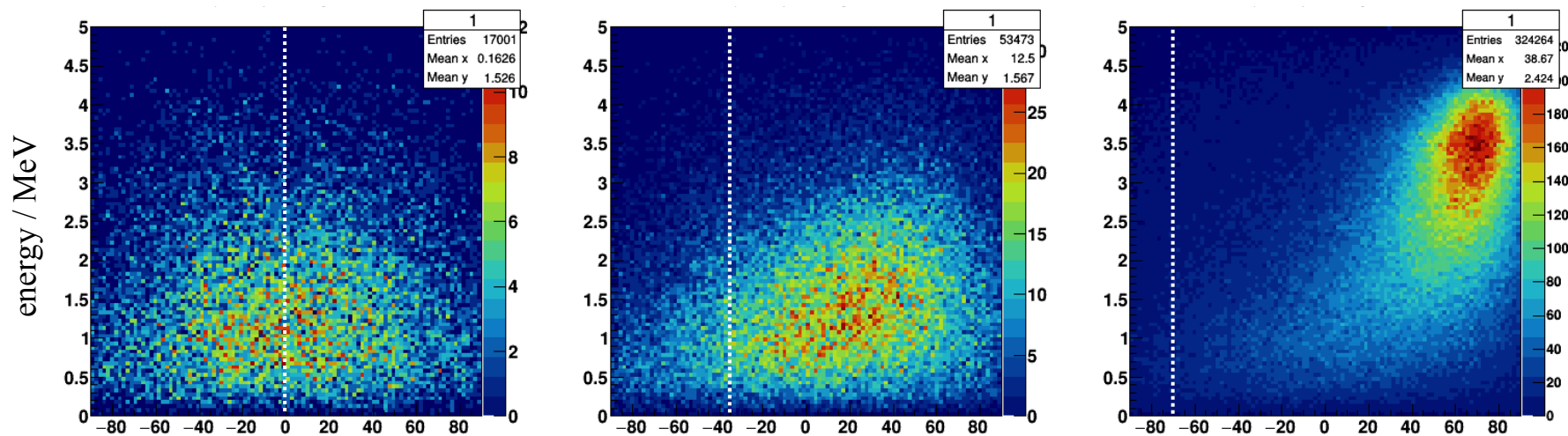
- Geant4 simulation

- beam: pencil-like, 5 MeV electrons, 10^6 particles
- geometry: beam hits Al-target under three different angles wrt. target surface:

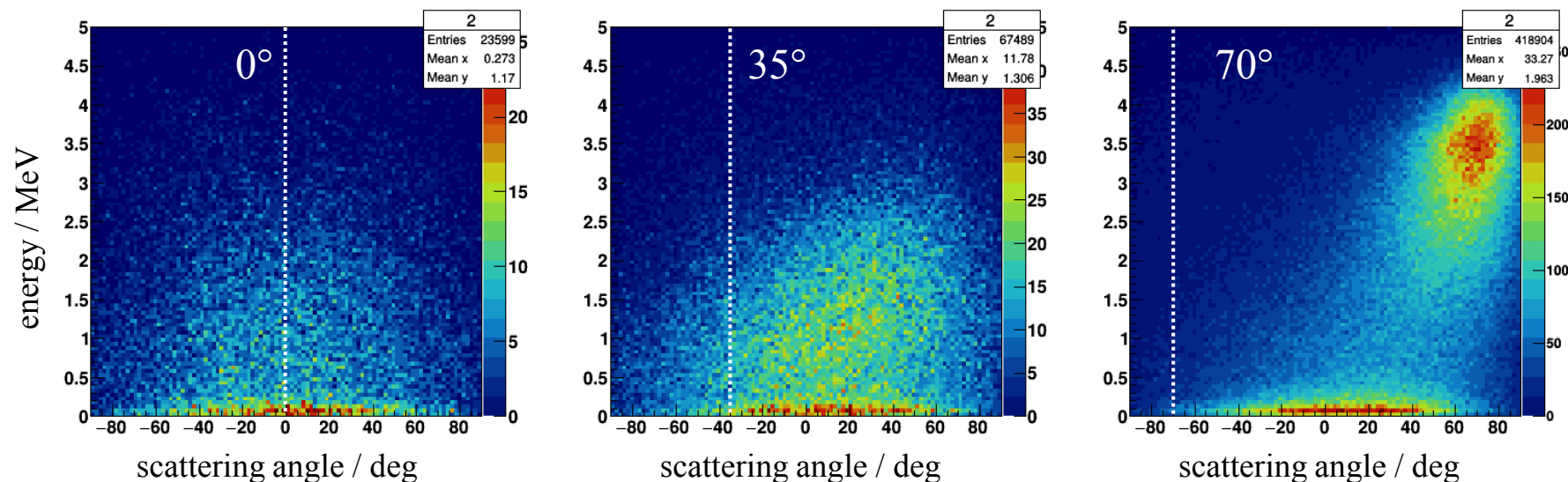


Simulation Results (1)

primary electrons, scattered from Al substrate

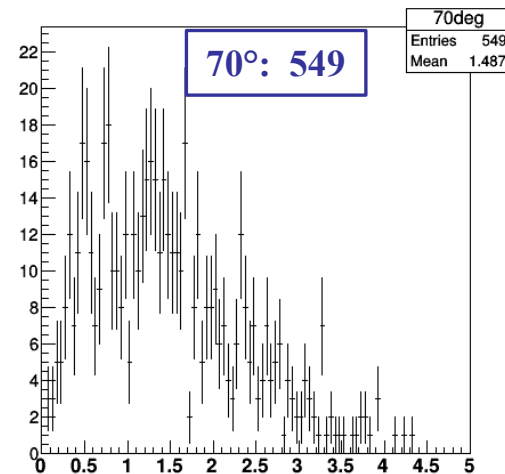
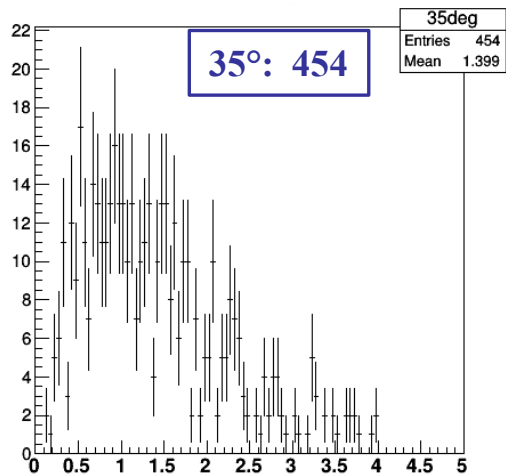
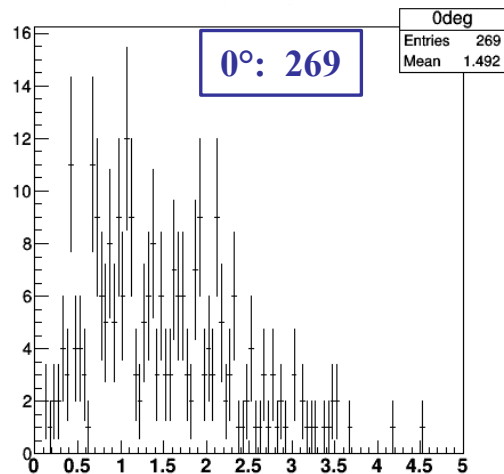


primary and secondary electrons, scattered from Al substrate

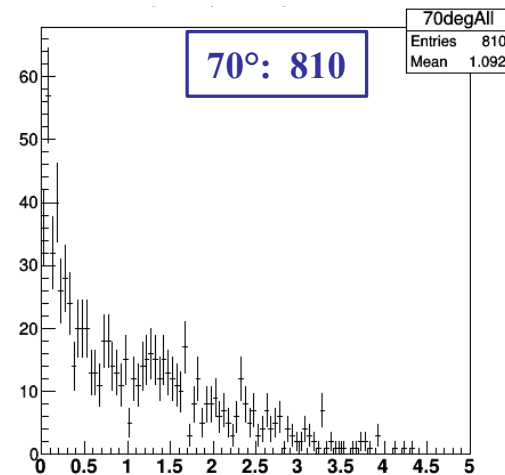
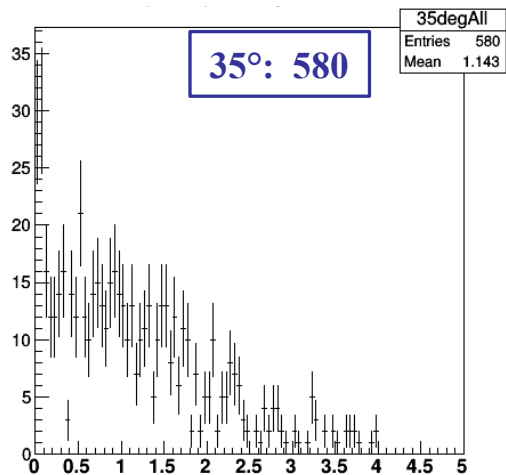
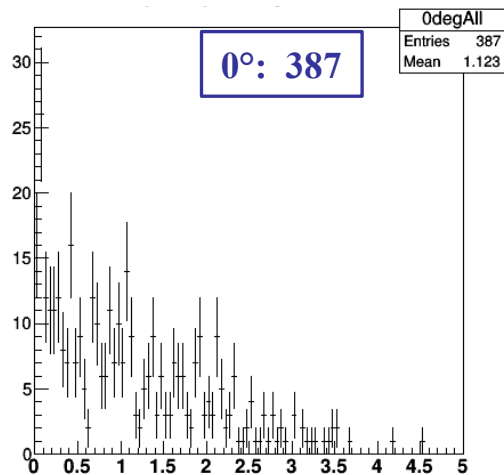


Simulation Results (2)

primary electrons, scattered from Al substrate



primary and secondary electrons, scattered from Al substrate



energy / MeV

energy / MeV

energy / MeV

Design Considerations

recapitulation

- material: Al → vacuum requirements & backscattering
- geometry: normal incidence → backscattering
- suppressor electrode: no need → backscatter energies to high

requirement

- compact design: stopping power
→ characterization via CSDA range
(Continuous Slowing Down Approximation)

- estar (NIST) calculation → 5 MeV

	Z	$R_{\text{csda}}/\text{mm}$
C	6	17.09
Al	13	11.46
Cu	29	3.80
Ag	47	3.33
Au	79	1.90

<http://physics.nist.gov/PhysRefData/Star/Text/ESTAR.html>

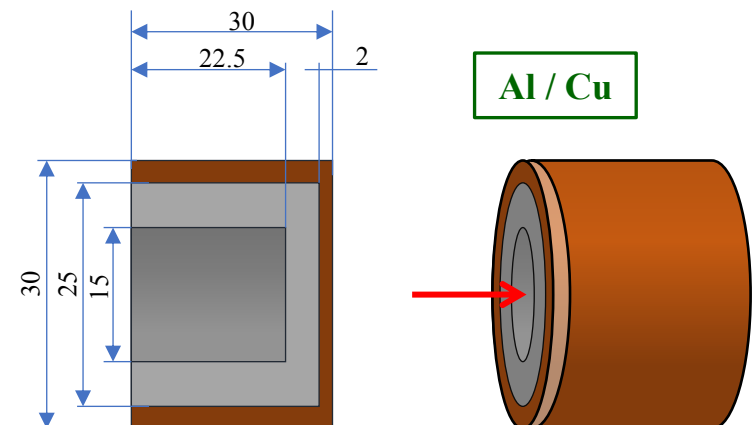


Al not best choice...



material combination:

- low Z: low backscattering
- high Z: high stopping power



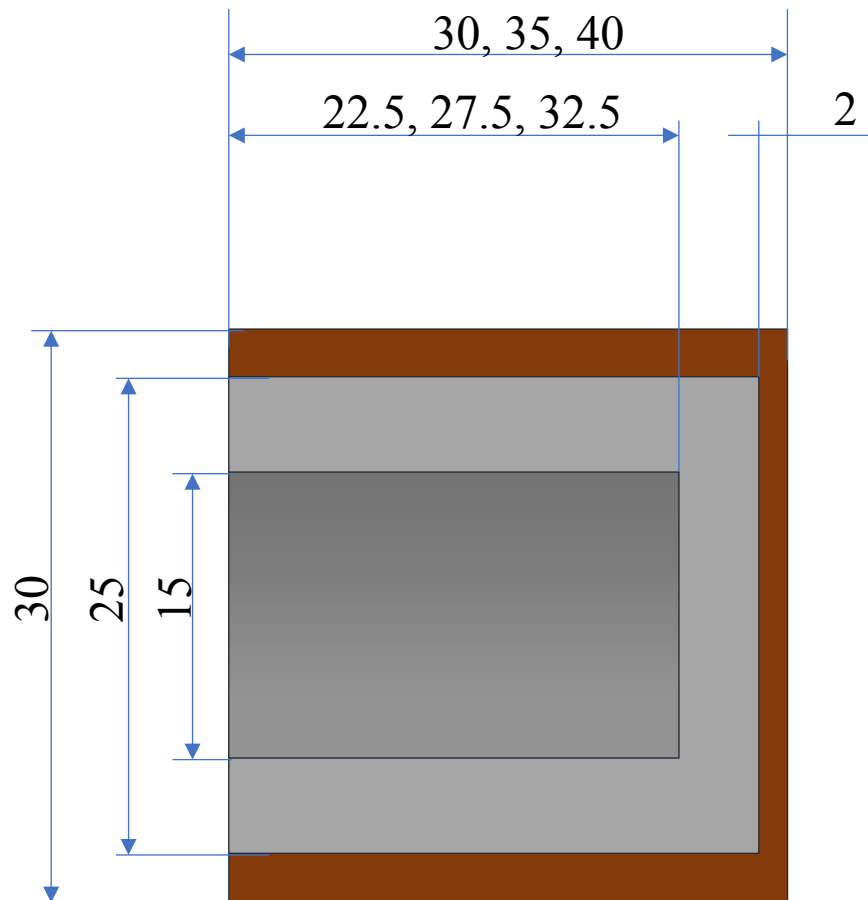
further optimization option

- solid angle for particle escape

Influence of Solid Angle

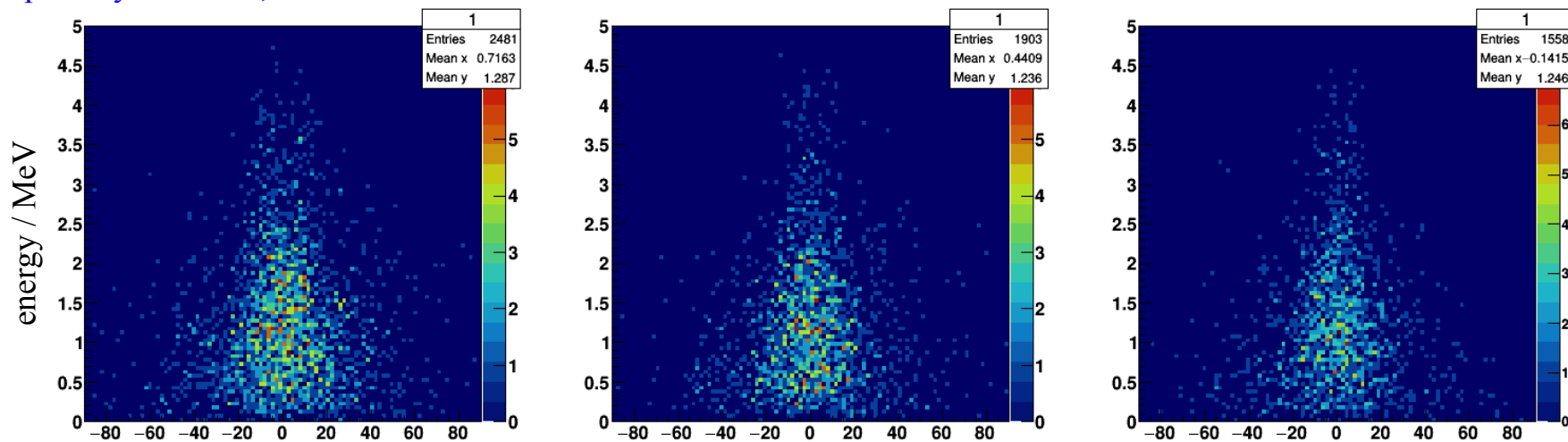
● FC length variation

- 3 different FC lengths: 30mm, 35mm, 40mm
- keep bottom thickness of FC constant: 7.5mm Al + 2mm Cu

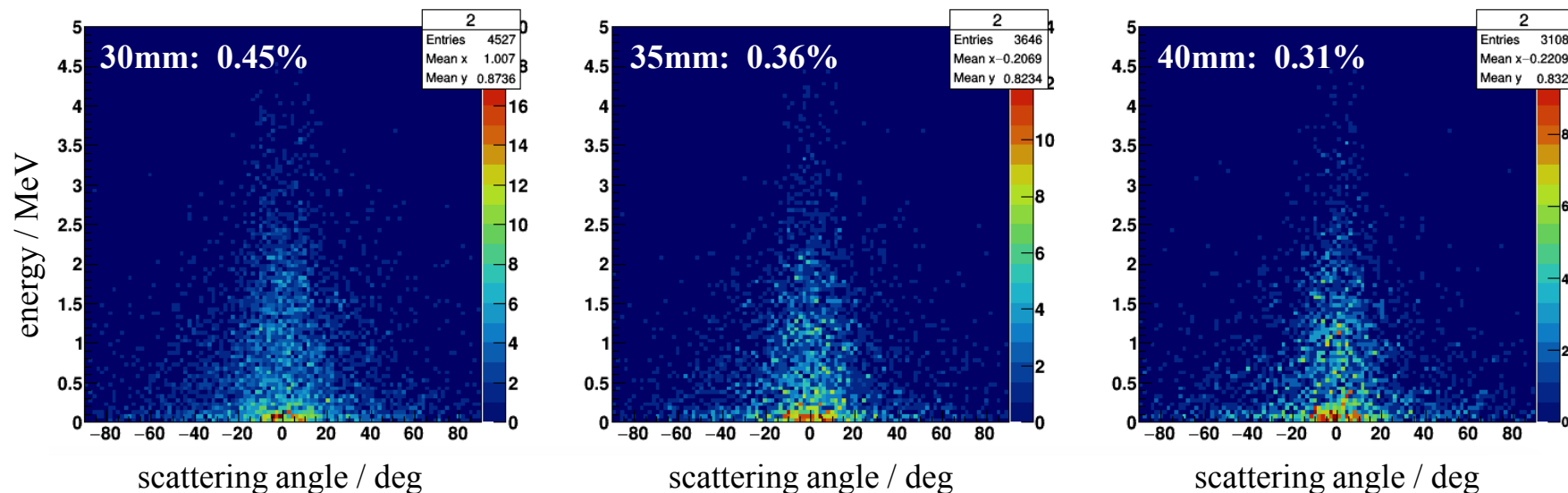


Simulation Results (1)

primary electrons, backscattered from FC

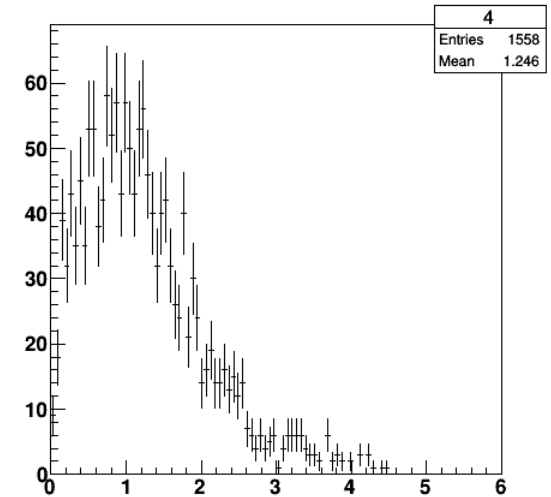
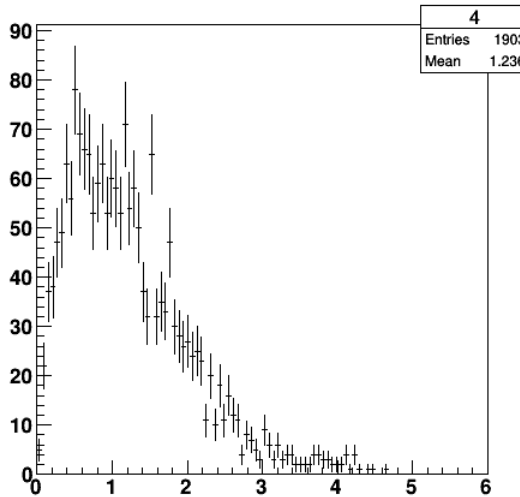
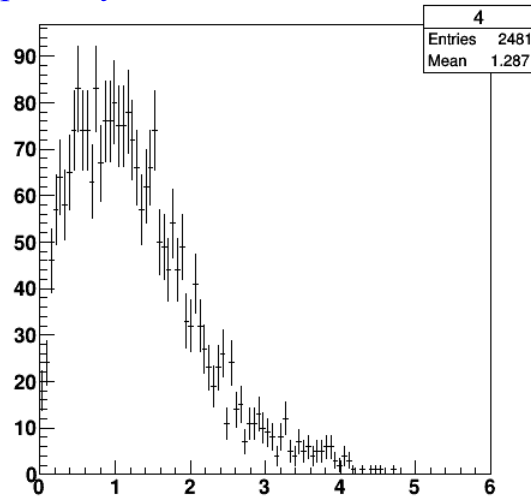


primary and secondary electrons, backscattered from FC

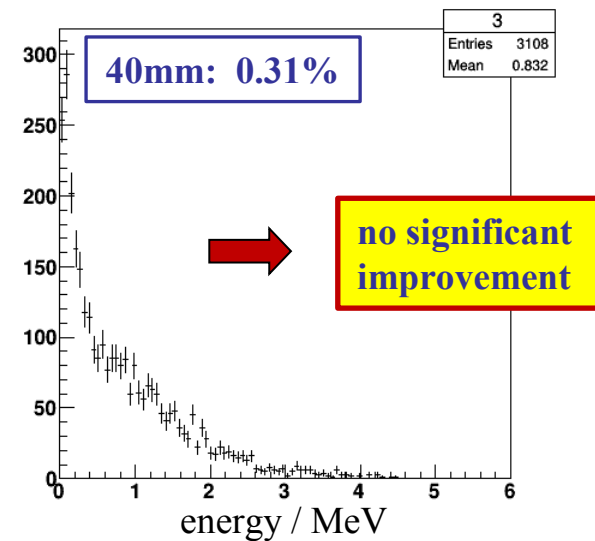
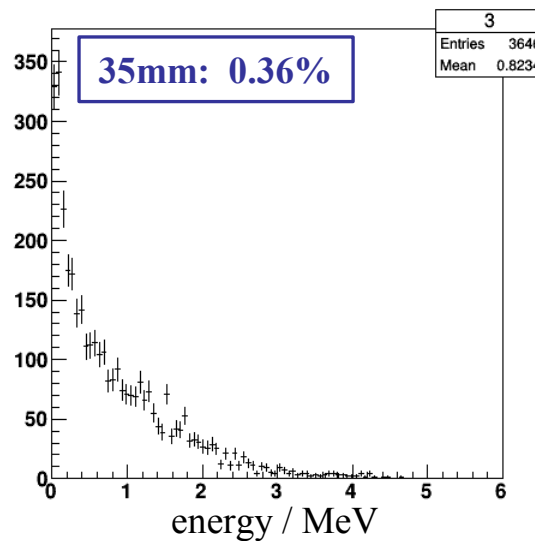
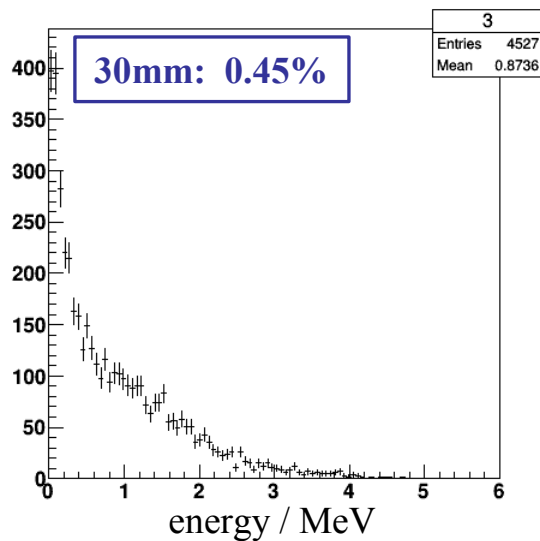


Simulation Results (2)

primary electrons, backscattered from FC



primary and secondary electrons, backscattered from FC



Summary and Outlook

● design study for compact Faraday cup

- 5 MeV electrons
- particle-free vacuum conditions
- compact design

● investigation of particle leakage

- backscattering is dominant loss process
 - material choice: **low Z**
 - tilt angle of stopping surface: **normal incidence**
 - depth of cup L_{FC} : **less important**

(P. Strehl, *Beam Diagnostics and Instrumentation*, Springer (2006): for $L_{FC} > R$)

● compact FC design

- simulated particle losses $\sim 0.45\%$

● change of specifications

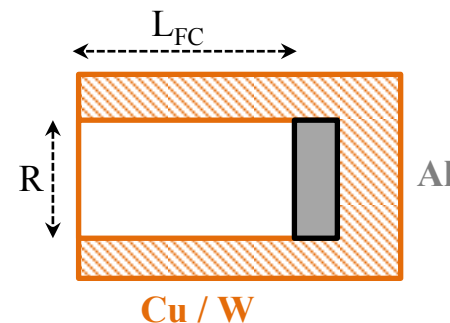
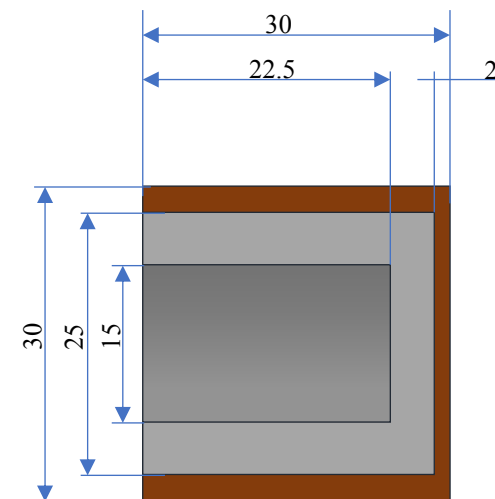
- outer dimensions to large... → new simulations under way...

● what happens, if a monitor is not designed by a beam diagnostician...

● heat load

- not considered, but uncritical

$$\rightarrow Q_b = 0.5 - 30 \text{ pCb}$$



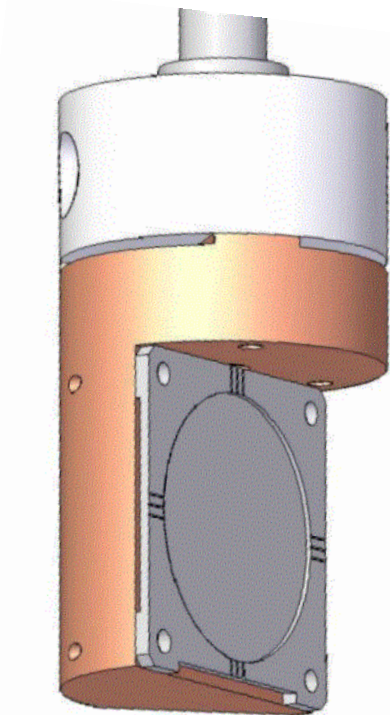
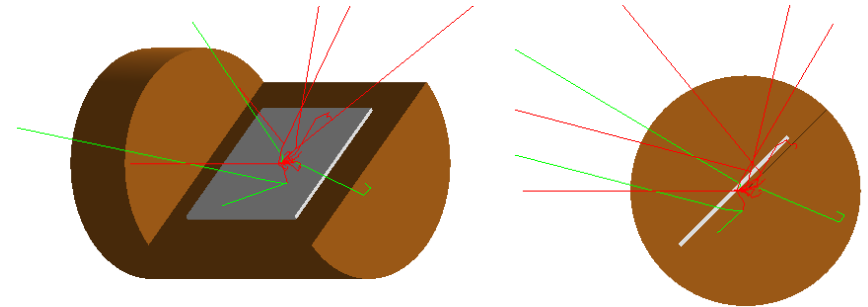
Simulation of present FC Design

● Cu based FC

- ▶ 0.5mm thick Al plate placed 1mm above surface
 - covered with YAG powder (screen)
- ▶ surface tilted by 45°
 - observation geometry for screen

● Geant4 simulation

- ▶ 10^6 primary electrons



energy distribution of electrons escaping from FC

